

TUL1203

NPN SILICON TRANSISTOR

HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

DESCRIPTION

The **TUL1203** is manufactured by using high voltage Planar technology for high voltage capability and high switching speeds.

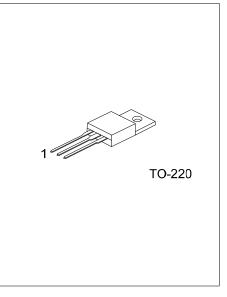
FEATURES

- * BV_{CES} Up To 1400V.
- * Better Distribution Of Dynamic Parameters And Lot To Lot Spread

- (3)Green Package

* High Switching Speed

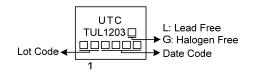
ORDERING INFORMATION



(3) G: Halogen Free and Lead Free, L: Lead Free

Ordering Number		Daakaga	Pir	Packing			
Lead Free Plating	Halogen-Free	Package	1	2	3	Packing	
TUL1203L-TA3-T	TUL1203G-TA3-T	TO-220	В	С	Е	Tube	
Note: Pin Assignment: B: Base C: Collector E: Emitter							
TUL1203G-TA3-T (1)Packing Type (2)Package Type		(1) T: Tube	9				
		(2) TA3: TO	D-220				

MARKING	



ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	RATINGS	UNIT
Collector-Base Voltage ($I_E = 0$)	V _{CBO}	1400	V
Collector-Emitter Voltage (V _{BE} = 0)	V _{CES}	1400	V
Collector-Emitter Voltage ($I_B = 0$)	V _{CEO}	550	V
Emitter-Base Voltage (I _C = 0)	V _{EBO}	12	V
Collector Current	Ιc	5	А
Collector Peak Current (t _p <5 ms)	I _{CM}	8	А
Base Current	Ι _Β	2	А
Base Peak Current (t _p <5 ms)	I _{BM}	4	А
Power Dissipation ($T_c = 25^{\circ}C$)	PD	100	W
Junction Temperature	TJ	+150	°C
Storage Temperature	T _{STG}	-65 ~ +150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Case	θ」	1.25	°C /W

ELECTRICAL CHARACTERISTICS (T_c = 25°C unless otherwise specified)

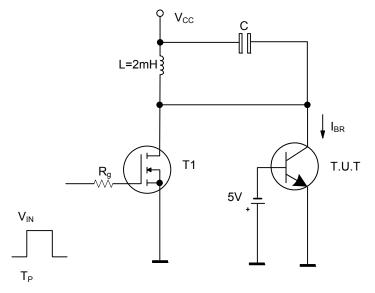
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Collector Cut-off Current (V			V _{CE} =1400V			100	μA
Emitter Cut-off Current (I _B =	mitter Cut-off Current ($I_B = 0$)		V _{EB} =12V			100	μA
Collector-Emitter Sustaining (Note)	g Voltage (I _B = 0)	V _{CEO(SUS)}	I _C =100mA	550		V	
	<u> </u>		I _C =1A, I _B =200mA			0.5	V
Collector-Emitter Saturation Voltage (Note)		V _{CE(SAT)}	I _C =2A, I _B =400mA			0.7	V
			I _C =3A, I _B =1A			1.5	V
Deep Emitter Optimation Voltage (Nate)		V _{BE(SAT)}	I _C =2A, I _B =400mA			1.5	V
	er Saturation Voltage (Note)		I _C =3A, I _B =1A			1.5	V
			I _C =1mA, V _{CE} =5V	10			
DC Current Cain (Note)		h	I _C =10mA, V _{CE} =5V	10			
DC Current Gain (Note)		h _{FE}	I _C =0.8A, V _{CE} =3V	14		32	
			I _C =2A, V _{CE} =5V	9		28	
	Storage Time	ts	I _C =2A, V _{CC} =150V		2.5	3.0	μs
Resistive Load	Fall Time	t⊧	I _{B1} =0.4A, I _{B2} =-0.8A, T _P =30μs		0.2	0.3	μs
Avalanche Energy		E _{AR}	L=2mH,C=1.8nF I _{BR} ≤2.5A,25°C <t<sub>C<125°C</t<sub>	6			mJ

Note: Pulse Test: Pulse width = 300µs, Duty cycle≤1.5%

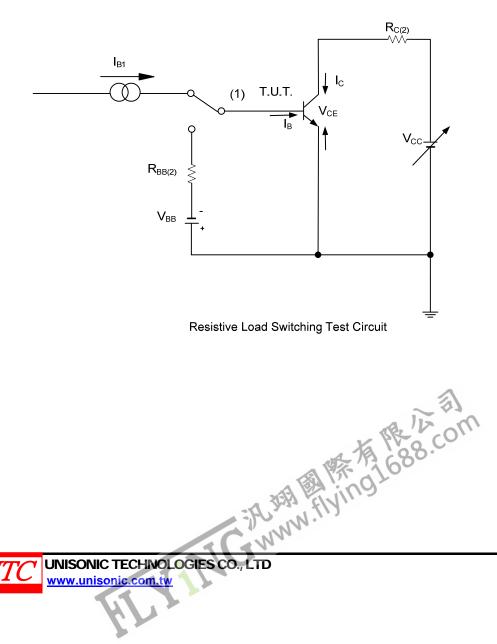


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TEST CIRCUITS



Energy Rating Test Circuit

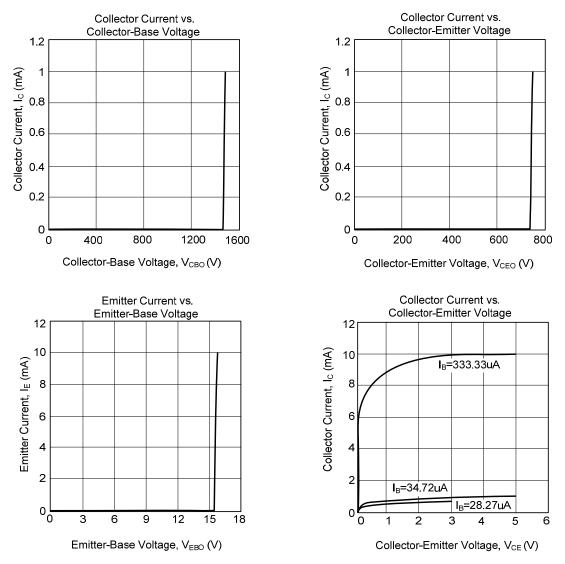




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TYPICAL CHARACTERISTICS



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